

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/806,419	PAPATHANASSIU, E.	ADONIA
	Examiner	Art Unit	
	Christopher H. Yaen	1643	

	SEARCHED			
Class	Subclass	Date	Examiner	
	. =			
	···-			
		,		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
palm inventor search	7/5/2006	CHY	
west- enclosed	7/5/2006	СНҮ	
STN database search	7/5/2006	CHY	
STIC sequence search - SEQ ID No: 4,8,9	7/5/2006	CHY	